

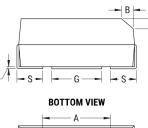
T541X336M050AT6710

T541 HRA, Tantalum, Polymer Tantalum, HRA Multi-Anode, 33 uF, 20%, 50 VDC, SMD, Polymer, Molded, High Reliability, Multi-Anode, Low ESR, N/A, 75 mOhms, 7343, Height Max = 4.3mm

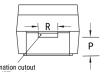
CATHODE (-) END VIEW

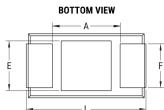


ANODE (+) END VIEW



SIDE VIEW





Termination cutout at KEMET's option, either end

Click here for the 3D model.

Dimensions	
Footprint	7343
L	7.3mm +/-0.3mm
W	4.3mm +/-0.3mm
Н	4mm +/-0.3mm
т	0.13mm REF
S	1.3mm +/-0.3mm
F	2.4mm +/-0.1mm
А	3.8mm MIN
В	0.5mm +/-0.15mm
E	3.5mm REF
G	3.5mm REF
Р	1.7mm REF
R	1mm REF
Х	0.1mm +/-0.1mm

т

Packaging Specifications	
Packaging	T&R, 178mm
Packaging Quantity	500

General Information	
Series	T541 HRA
Dielectric	Polymer Tantalum
Style	SMD Chip
Description	SMD, Polymer, Molded, High Reliability, Multi- Anode, Low ESR
Features	Non-Combustible, Multiple Anode, Low ESR, High Reliability
RoHS	Yes
Termination	Tin
AEC-Q200	No
Component Weight	410.89 mg
Shelf Life	52 Weeks
MSL	3

Specifications Capacitance 33 uF Capacitance 20% Voltage DC 50 VDC (105C), 33.5 VDC (125C) Temperature -55/+125°C
Capacitance 20% Tolerance 20% Voltage DC 50 VDC (105C), 33.5 VDC (125C) Temperature -55/±125°C
Tolerance 20% Voltage DC 50 VDC (105C), 33.5 VDC (125C) Temperature -55/±125°C
Temperature _55/+125°C
-55/+1/5
Rated 105°C Temperature
Humidity 60C, 90% RH, 500 Hours, rated voltage
Dissipation 10% 120Hz 25C Factor
Failure Rate N/A
Resistance 75 mOhms (100kHz 25C)
Ripple Current 1897 mA (rms, 100kHz 45C)
Leakage Current 165 uA (5min 25°C)
Testing and10 Cycles Surge Current Testing At -55C +0C/-Reliability5C And +85C +/-5C After Voltage Aging

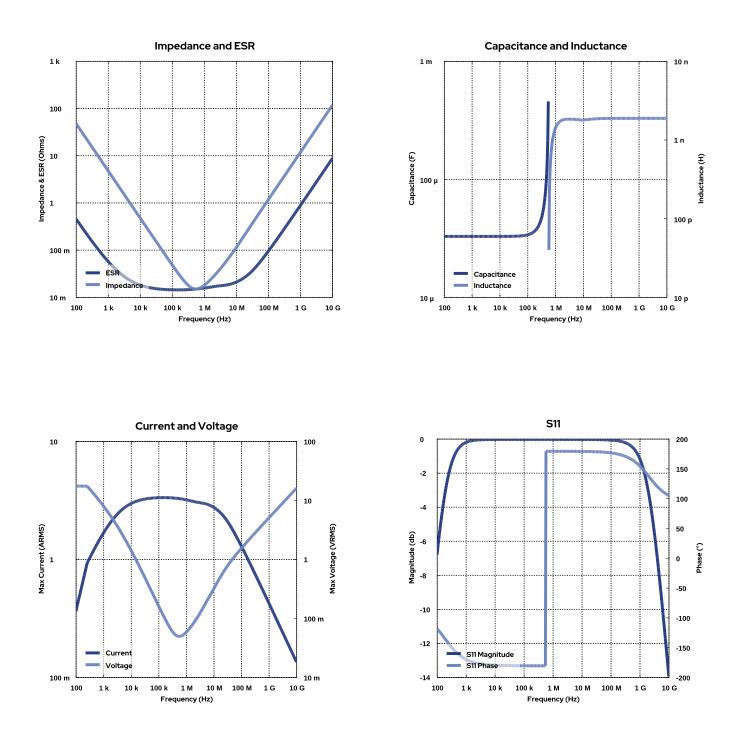
Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute - and we specifically disclaim - any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.



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Simulations

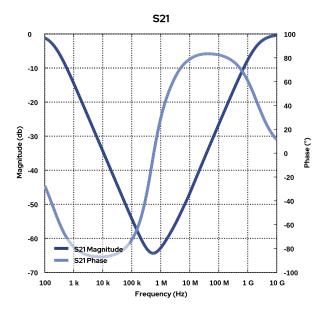
For the complete simulation environment please visit K-SIM.







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These are simulations

This is not a specification!

The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

The responses shown do not represent a specified or implied maximum capability of the device for all applications.

- The ESR used for ripple "Ripple Current/Voltage vs. Frequency" plots is the ESR at ambient temperature.
- The ESR in the "Temperature Rise vs. Ripple Current" plots is adjusted to each incremental temperature rise before the power and ripple current is calculated.
- The effects shown herein are based on measured data from a multiple part sample of the parts in question.
- Ripple capability of this device will be factored by thermal resistance (Rth) created by circuit traces (addi affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance. The peak voltages generated in the "Temperature Rise vs. Combined Ripple Currents" plot are calculated for each frequency and are not combined with voltages generated at any other
- harmonics
- Please consult with the catalog or field applications engineer for maximum capability of the device in specific applications.

All product information and data (collectively, the "Information") are subject to change without notice.

KEMET K-SIM is designed to simulate behavior of components with respect to frequency, ambient temperature, and DC bias levels. The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation effects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

All Information given herein is believed to be accurate and reliable, but is presented without guarantee, warranty, or responsibility of any kind, expressed or implied. Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute – and we specifically disclaim – any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.

If you have any questions please contact K-SIM.

单击下面可查看定价,库存,交付和生命周期等信息

>>KEMET(基美)